



Data sheet acquired from Harris Semiconductor
SCHS049A – Revised March 2002

CMOS 14-Stage Ripple-Carry Binary Counter/Divider and Oscillator

High-Voltage Types (20-Volt Rating)

■ CD4060B consists of an oscillator section and 14 ripple-carry binary counter stages. The oscillator configuration allows design of either RC or crystal oscillator circuits. A RESET input is provided which resets the counter to the all-0's state and disables the oscillator. A high level on the RESET line accomplishes the reset function. All counter stages are master-slave flip-flops. The state of the counter is advanced one step in binary order on the negative transition of ϕ_1 (and ϕ_0). All inputs and outputs are fully buffered. Schmitt trigger action on the input-pulse line permits unlimited input-pulse rise and fall times.

The CD4060B-series types are supplied in 16-lead hermetic dual-in-line ceramic packages (D and F suffixes), 16-lead dual-in-line plastic packages (E suffix), 16-lead small-outline package (NSR suffix), and in chip form (H suffix).

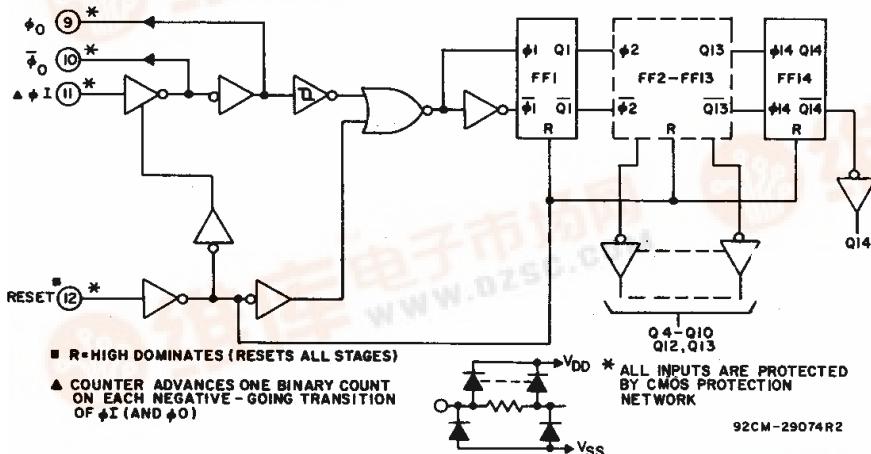


Fig. 1 – Logic diagram.

MAXIMUM RATINGS; Absolute Maximum Values:

DC SUPPLY-VOLTAGE RANGE, (V_{DD})

Voltages referenced to V_{SS} Terminal) -0.5V to +20V

INPUT VOLTAGE RANGE, ALL INPUTS

..... -0.5V to V_{DD} + 0.5V

DC INPUT CURRENT, ANY ONE INPUT

..... ±10mA

POWER DISSIPATION PER PACKAGE (P_D)

For T_A = -55°C to +100°C 500mW

For T_A = +100°C to +125°C Derate Linearity at 12mW/°C to 200mW

DEVICE DISSIPATION PER OUTPUT TRANSISTOR

FOR T_A = FULL PACKAGE-TEMPERATURE RANGE (All Package Types) 100mW

OPERATING-TEMPERATURE RANGE (T_A)

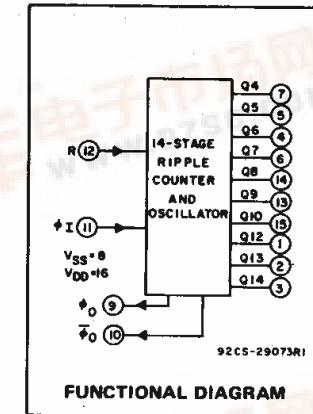
..... -55°C to +125°C

STORAGE TEMPERATURE RANGE (T_{stg})

..... -65°C to +150°C

LEAD TEMPERATURE (DURING SOLDERING):

At distance 1/16 ± 1/32 inch (1.59 ± 0.79mm) from case for 10s max +265°C



Applications

- Control counters
- Timers
- Frequency dividers
- Time-delay circuits

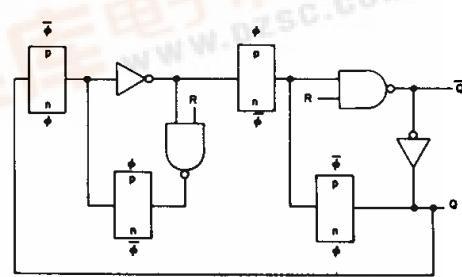


Fig. 2 – Detail of typical flip-flop stage.

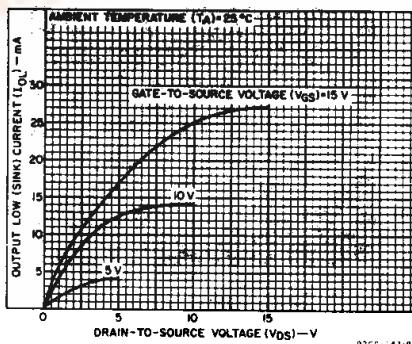


Fig. 3 – Typical n-channel output low (sink) current characteristics.

CD4060B Types

STATIC ELECTRICAL CHARACTERISTICS

CHARAC- TERISTIC	CONDITIONS			LIMITS AT INDICATED TEMPERATURES (°C)						U N I T S	
	V_O (V)	V_{IN} (V)	V_{DD} (V)	+25				Min.	Typ.	Max.	
				-55	-40	+85	+125				
Quiescent Device Current, I_{DD} Max.	-	0.5	5	5	5	150	150	-	0.04	5	μA
	-	0.10	10	10	10	300	300	-	0.04	10	
	-	0.15	15	20	20	600	600	-	0.04	20	
	-	0.20	20	100	100	3000	3000	-	0.08	100	
Output Low (Sink) Current*, I_{OL} Min.	0.4	0.5	5	0.64	0.61	0.42	0.36	0.51	1	-	mA
	0.5	0.10	10	1.6	1.5	1.1	0.9	1.3	2.6	-	
	1.5	0.15	15	4.2	4	2.8	2.4	3.4	6.8	-	
Output High (Source) Current*, I_{OH} Min.	4.6	0.5	5	-0.64	-0.61	-0.42	-0.36	-0.51	-1	-	mA
	2.5	0.5	5	-2	-1.8	-1.3	-1.15	-1.6	-3.2	-	
	9.5	0.10	10	-1.6	-1.5	-1.1	-0.9	-1.3	-2.6	-	
	13.5	0.15	15	-4.2	-4	-2.8	-2.4	-3.4	-6.8	-	
Output Voltage: Low-Level, V_{OL} Max.	-	0.5	5	0.05			-	0	0.05	-	V
	-	0.10	10	0.05			-	0	0.05	-	
	-	0.15	15	0.05			-	0	0.05	-	
Output Voltage: High-Level, V_{OH} Min.	-	0.5	5	4.95			4.95	5	-	-	V
	-	0.10	10	9.95			9.95	10	-	-	
	-	0.15	15	14.95			14.95	15	-	-	
Input Low Voltage V_{IL} Max.	0.5,4.5	-	5	1.5			-	-	1.5	-	V
	1.9	-	10	3			-	-	3	-	
	1.5,13.5	-	15	4			-	-	4	-	
Input High Voltage, V_{IH} Min.	0.5,4.5	-	5	3.5			3.5	-	-	-	V
	1.9	-	10	7			7	-	-	-	
	1.5,13.5	-	15	11			11	-	-	-	
Input Current I_{IN} Max.	-	0.18	18	± 0.1	± 0.1	± 1	± 1	-	$\pm 10^{-5}$	± 0.1	μA

* Data not applicable to terminal 9 or 10.

RECOMMENDED OPERATING CONDITIONS

For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges

CHARACTERISTIC	V_{DD}	LIMITS		UNITS
		MIN.	MAX.	
Supply-Voltage Range (For $T_A =$ Full Package Temperature Range)	-	3	18	V
Input-Pulse Width, t_W ($f = 100$ kHz)	5 10 15	100 40 30	-	ns
Input-Pulse Rise Time and Fall Time, $t_{r\phi}, t_{f\phi}$	5 10 15	Unlimited		
Input-Pulse Frequency, f_{ϕ} (External pulse source)	5 10 15	-	3.5 8 12	MHz
Reset Pulse Width, t_W	5 10 15	120 60 40	-	ns

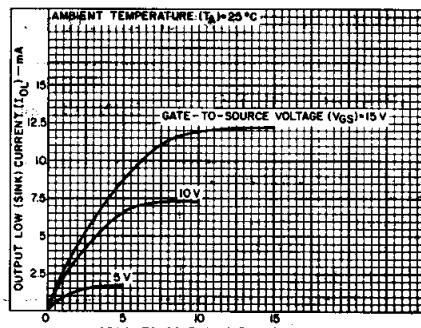


Fig. 4 – Minimum n-channel output low (sink) current characteristics.

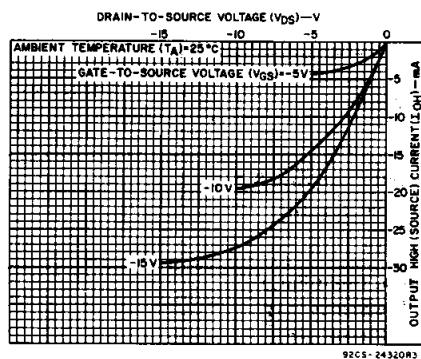


Fig. 5 – Typical p-channel output high (source) current characteristics.

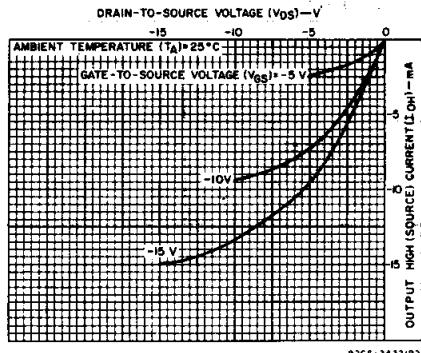


Fig. 6 – Minimum p-channel output high (source) current characteristics.

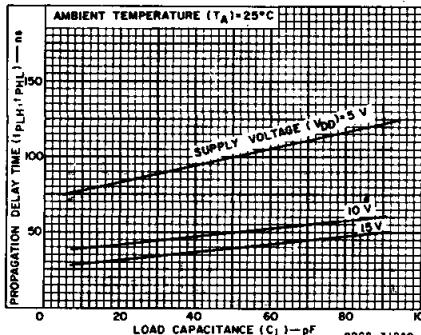


Fig. 7 – Typical propagation delay time (t_{PHL}) as a function of load capacitance.

CD4060B Types

DYNAMIC ELECTRICAL CHARACTERISTICS at $T_A = 25^\circ\text{C}$, Input $t_r, t_f = 20 \text{ ns}$,
 $C_L = 50 \text{ pF}$, $R_L = 200 \text{ k}\Omega$

CHARACTERISTIC	TEST CONDITIONS	LIMITS			UNITS
		V _{DD} (V)	MIN.	TYP.	
Input-Pulse Operation					
Propagation Delay Time, ϕ_1 to Q4 Out; t _{PHL} , t _{PLH}		5	—	370	740
		10	—	150	300
		15	—	100	200
Propagation Delay Time, Q _n to Q _{n+1} ; t _{PHL} , t _{PLH}		5	—	100	200
		10	—	50	100
		15	—	40	80
Transition Time, t _{THL} , t _{TLH}		5	—	100	200
		10	—	50	100
		15	—	40	80
Min. Input-Pulse Width, t _W	f = 100 kHz	5	—	50	100
		10	—	20	40
		15	—	15	30
Input-Pulse Rise & Fall Time, t _{rφ} , t _{fφ}		5	Unlimited		
		10	Unlimited		
		15	Unlimited		
Max. Input-Pulse Frequency, f _φ (External pulse source)		5	3.5	7	—
		10	8	16	—
		15	12	24	—
Input Capacitance, C _I	Any Input	—	5	7.5	pF
Reset Operation					
Propagation Delay Time, t _{PHL}		5	—	180	360
		10	—	80	160
		15	—	50	100
Minimum Reset Pulse Width, t _W		5	—	60	120
		10	—	30	60
		15	—	20	40

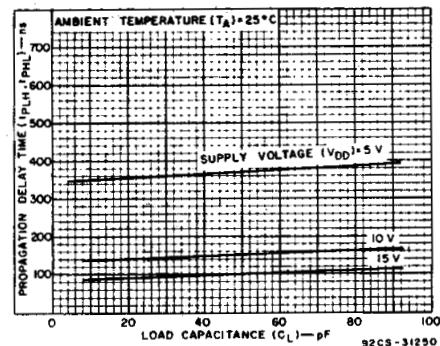


Fig. 8 – Typical propagation delay time (ϕ_1 to Q₄ Output) as a function of load capacitance.

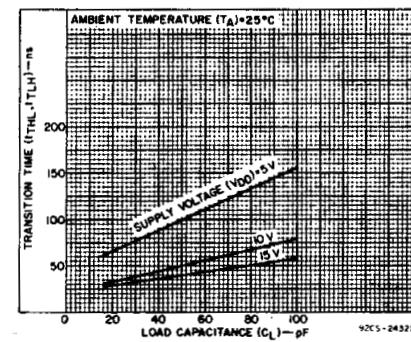


Fig. 9 – Typical transition time as a function of load capacitance.

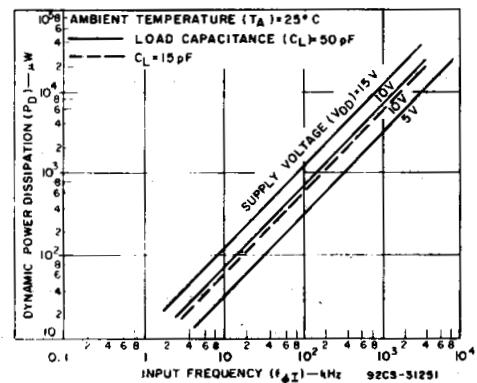


Fig. 10 – Typical dynamic power dissipation as a function of input frequency.

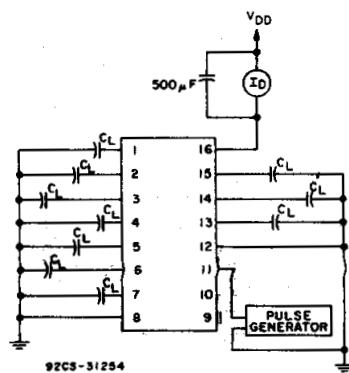


Fig. 11 – Dynamic power dissipation test circuit.

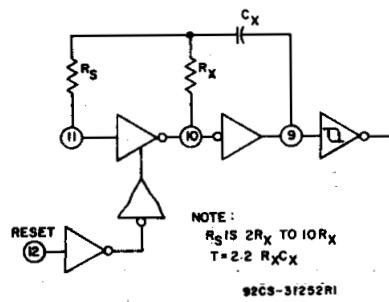


Fig. 12 – Typical RC circuit.

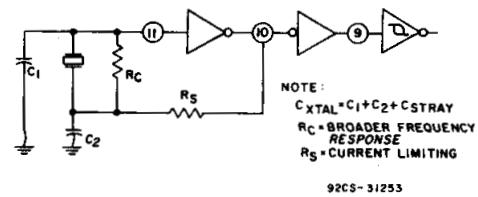


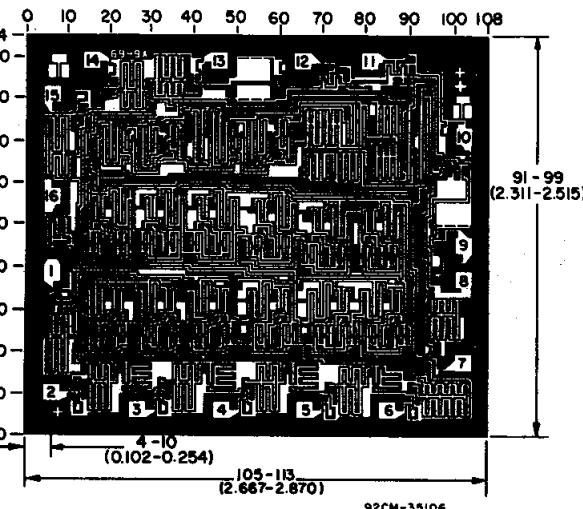
Fig. 13 – Typical crystal circuit.

CD4060B Types

DYNAMIC ELECTRICAL CHARACTERISTICS at $T_A = 25^\circ\text{C}$, Input $t_r, t_f = 20 \text{ ns}$,
 $C_L = 50 \text{ pF}, R_L = 200 \text{ k}\Omega$ [cont'd]

CHARACTERISTIC	TEST CONDITIONS	V _{DD} (V)	LIMITS			UNITS
			Min.	Typ.	Max.	
RC Operation						
Variation of Frequency (Unit-to-Unit)	$C_X = 200 \text{ pF}$, $R_S = 560 \text{ k}\Omega$, $R_X = 50 \text{ k}\Omega$	5	—	$23 \pm 10\%$	—	kHz
		10	—	$24 \pm 10\%$	—	
		15	—	$25 \pm 10\%$	—	
Variation of Frequency with voltage change (Same Unit)	$C_X = 200 \text{ pF}$, $R_S = 560 \text{ k}\Omega$, $R_X = 50 \text{ k}\Omega$	5V to 10 V	—	1.5	—	
		10V to 15V	—	0.5	—	
R_X max.	$C_X = 10 \mu\text{F}$ = $50 \mu\text{F}$ = $10 \mu\text{F}$	5	—	—	20	MΩ
		10	—	—	20	
		15	—	—	10	
C_X max.	$R_X = 500 \text{ k}\Omega$ = $300 \text{ k}\Omega$ = $300 \text{ k}\Omega$	5	—	—	1000	μF
		10	—	—	50	
		15	—	—	50	
Maximum Oscillator Frequency*	$R_X = 5 \text{ k}\Omega$ $R_S = 30 \text{ k}\Omega$ $C_X = 15 \text{ pF}$	10	530	650	810	kHz
		15	690	800	940	
Drive Current at Pin 9 (For Oscillator Design)	$V_O = 0.4 \text{ V}$	5	0.16	0.35	—	mA
	= 0.5 V	10	0.42	0.8	—	
	= 1.5 V	15	1	2	—	
I_{OL}	$V_O = 4.6 \text{ V}$	5	-0.16	-0.35	—	
	= 9.5 V	10	-0.42	-0.8	—	
	= 13.5 V	15	-1	-2	—	
I_{OH}	$V_O = 4.6 \text{ V}$	5	-0.16	-0.35	—	
	= 9.5 V	10	-0.42	-0.8	—	
	= 13.5 V	15	-1	-2	—	

*RC oscillator applications are not recommended at supply voltages below 7 V for $R_X < 50 \text{ k}\Omega$.



Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils (10^{-3} inch).

Chip dimensions and pad layout for CD4060B

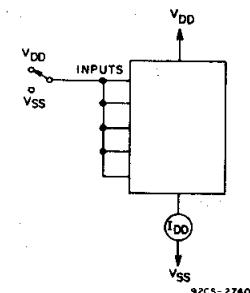


Fig. 14 – Quiescent device current.

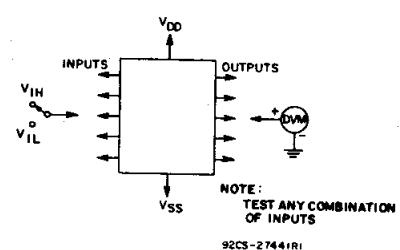


Fig. 15 – Input voltage.

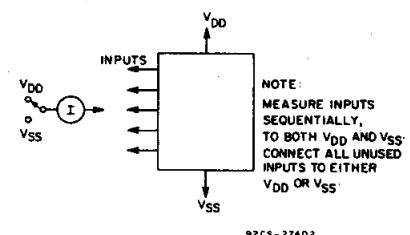
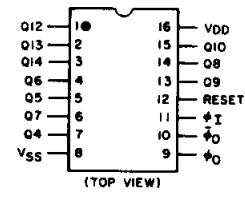


Fig. 16 – Input current.

TERMINAL DIAGRAM



IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Mailing Address:

Texas Instruments
Post Office Box 655303
Dallas, Texas 75265

Copyright © 2002, Texas Instruments Incorporated

